Application/Control No. 09/678,328 Examiner Yogesh K Aggarwal Applicant(s)/Patent Under Reexamination TAKANE ET AL. Page 1 of 1

Notice of References Cited

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,717,965	02-1998	lwasaki, Hiroyuki	396/233
	В	US-2001/@638417	11-2001	Uehara et al.	348/333.12
	С	US-6:09/1,908	07-2000	Fukuda, Hiroyuki	396/234
	D	US-5,838,370	11-1998	Kaji, Toshio	348/240.2
	Е	US-2002/0057352	05-2002	YAMAGISHI, YOICHI	348/232
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0				١	
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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